



16-Bit, Ultra-Low Power, Voltage-Output Digital-to-Analog Converters

FEATURES

- **Controlled Baseline**
 - One Assembly
 - One Test Site
 - One Fabrication Site
- **Extended Temperature Performance of -55°C to 125°C**
- **Enhanced Diminishing Manufacturing Sources (DMS) Support**
- **Enhanced Product-Change Notification**
- **Qualification Pedigree ⁽¹⁾**
- **16-Bit Resolution**
- **2.7-V to 5.5-V Single-Supply Operation**
- **Low Power: 15 μW for 3-V Power**
- **High Accuracy, INL: 1 LSB**
- **Low Glitch: 8 nV-s**
- **Low Noise: 10 nV/ $\sqrt{\text{Hz}}$**
- **Fast Settling: 1 μs**
- **Fast SPI Interface Up to 50 MHz**
- **Reset to Zero-Code**
- **Schmitt-Trigger Inputs for Direct Optocoupler Interface**
- **Industry-Standard Pin Configuration**

(1) Component qualification in accordance with JEDEC and industry standards to ensure reliable operation over an extended temperature range. This includes, but is not limited to, Highly Accelerated Stress Test (HAST) or biased 85/85, temperature cycle, autoclave or unbiased HAST, electromigration, bond intermetallic life, and mold compound life. Such qualification testing should not be viewed as justifying use of this component beyond specified performance and environmental limits.

APPLICATIONS

- **Portable Equipment**
- **Automatic Test Equipment**
- **Industrial Process Control**
- **Data Acquisition Systems**
- **Optical Networking**

DESCRIPTION

The DAC8830 and DAC8831 are single, 16-bit, serial-input, voltage-output digital-to-analog converters (DACs) operating from a single 3-V to 5-V power supply. These converters provide excellent linearity, low glitch, low noise, and fast settling over the specified temperature range of -55°C to 125°C . The output is unbuffered, which reduces the power consumption and the error introduced by the buffer.

These parts feature a standard high-speed (clock up to 50 MHz), 3-V or 5-V SPI serial interface to communicate with the DSP or microprocessors.

The DAC8830 output is 0 V to V_{REF} . However, the DAC8831 provides bipolar mode output ($\pm V_{\text{REF}}$) when working with an external buffer. The DAC8830 and DAC8831 are both reset to zero-code after power up.

For optimum performance, a set of Kelvin connections to external reference and analog ground input are provided on the DAC8831.

The DAC8830 is available in an SO-8 package and the DAC8831 is available in an SO-14 package. Both have industry standard pinouts (see [Table 3](#), the Cross Reference table in the *Application Information* section for details).



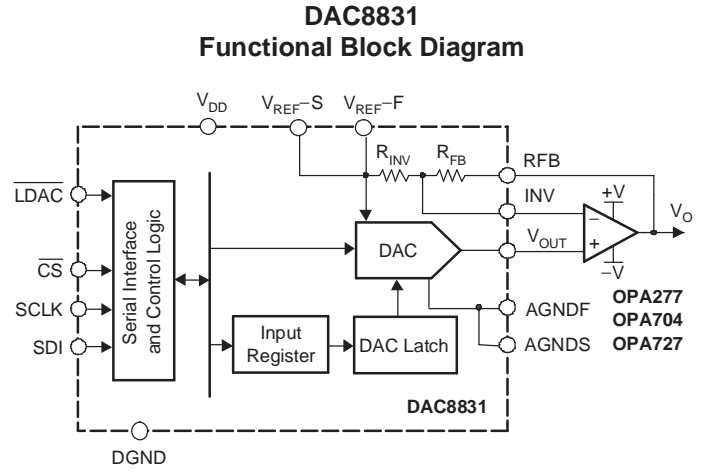
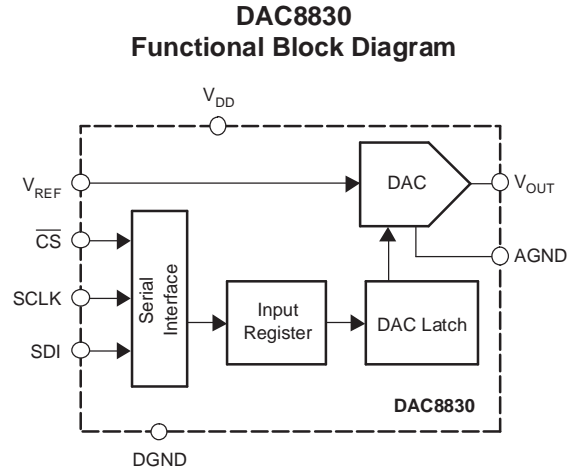
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This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because small parametric changes could cause the device not to meet its published specifications.

ORDERING INFORMATION⁽¹⁾

| PRODUCT | MINIMUM RELATIVE ACCURACY (LSB) | DIFFERENTIAL NONLINEARITY (LSB) | POWER-ON RESET VALUE | SPECIFICATION TEMPERATURE RANGE | PACKAGE MARKING | PACKAGE-LEAD | PACKAGE ⁽²⁾ DESIGNATOR | ORDERING NUMBER | TRANSPORT MEDIA, QUANTITY |
|------------|---------------------------------|---------------------------------|----------------------|---------------------------------|-----------------|--------------|-----------------------------------|-----------------|---------------------------|
| DAC8830MCD | ±1 | ±1 | Zero-Code | –55°C to 125°C | 8830M | SO-8 | D | DAC8830MCDREP | Tape and Reel, 2500 |
| | | | | | | | | DAC8830MCDEP | Tube, 75 |
| DAC8831MCD | ±1 | ±1 | Zero-Code | –55°C to 125°C | 8831M | SO-14 | D | DAC8831MCDREP | Tape and Reel, 2500 |
| | | | | | | | | DAC8831MCDEP | Tube, 50 |

(1) For the most current package and ordering information, see the Package Option Addendum at the end of this data sheet, or see the Texas Instruments website at www.ti.com.

(2) Package drawings, standard packing quantities, thermal data, symbolization, and PCB design guidelines are available at www.ti.com/sc/package.

ABSOLUTE MAXIMUM RATINGS

over operating free-air temperature range (unless otherwise noted)⁽¹⁾

| | VALUE | UNIT |
|---|---|-------|
| V_{DD} to AGND | –0.3 to 7 | V |
| Digital input voltage to DGND | –0.3 to $V_{DD} + 0.3$ | V |
| V_{OUT} to AGND | –0.3 to $V_{DD} + 0.3$ | V |
| AGND, AGNDF, AGNDS to DGND | –0.3 to 0.3 | V |
| Operating temperature range | –55 to 125 | °C |
| Storage temperature range | –65 to 150 | °C |
| Junction temperature range (T_J max) | 150 | °C |
| Power dissipation | $(T_J \text{ max} - T_A) / \theta_{JA}$ | W |
| Thermal impedance, θ_{JA} | SO-8 | 149.5 |
| | SO-14 | 104.5 |
| Lead temperature, soldering | Vapor phase (60 s) | 215 |
| | Infrared (15 s) | 220 |

(1) Stresses above those listed under absolute maximum ratings may cause permanent damage to the device. Exposure to absolute maximum conditions for extended periods may affect device reliability.

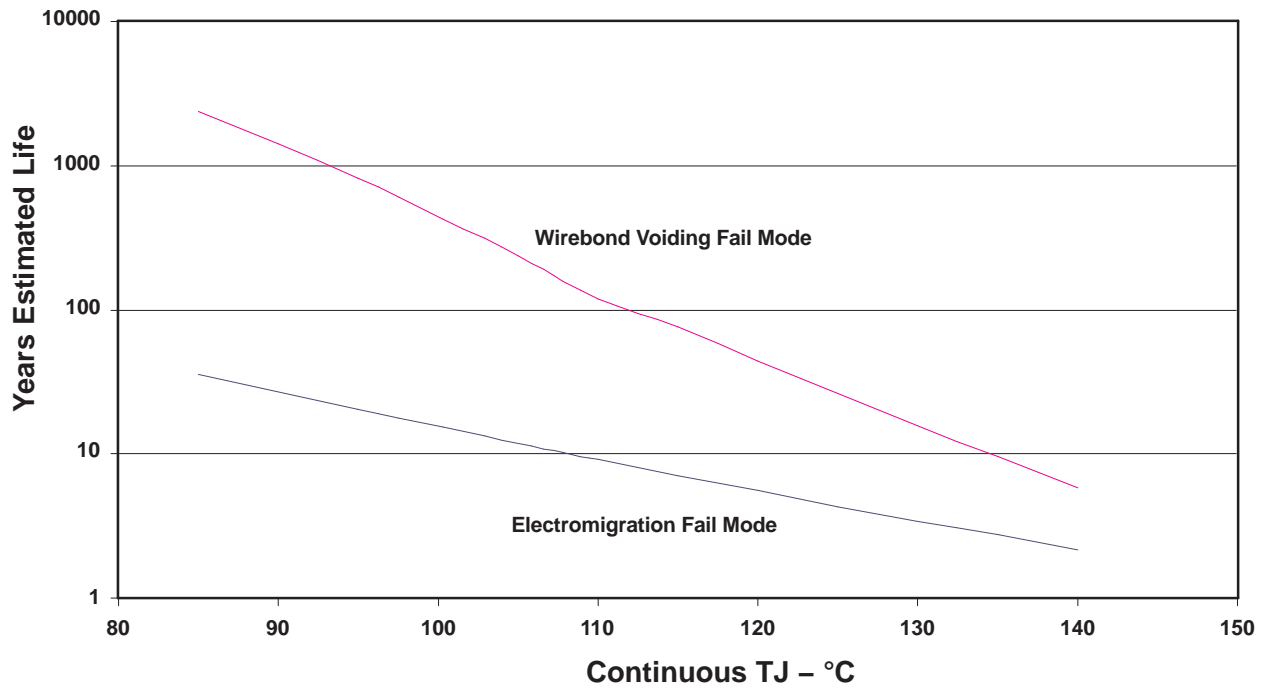


Figure 1. DAC8831MEP Operating Life Derating Chart

ELECTRICAL CHARACTERISTICS

All specifications at $T_A = T_{MIN}$ to T_{MAX} , $V_{DD} = 3\text{ V}$, or $V_{DD} = 5\text{ V}$, $V_{REF} = 2.5\text{ V}$ (unless otherwise noted); specifications subject to change without notice.

| PARAMETER | CONDITIONS | MIN | TYP | MAX | UNIT |
|------------------------------------|---|--|----------------|--------------|------------------------|
| STATIC PERFORMANCE | | | | | |
| Resolution | | 16 | | | bits |
| Linearity error | $T_A = 25^\circ\text{C}$ | | ± 0.5 | ± 1 | LSB |
| | $T_A = -40^\circ\text{C}$ to 105°C (DAC8831 only) | | ± 0.5 | ± 1.5 | |
| | $T_A = -55^\circ\text{C}$ to 125°C (DAC8831 only) | | | ± 4 | |
| | $T_A = -55^\circ\text{C}$ to 125°C (DAC8830 only) | | ± 0.5 | ± 1.5 | |
| Differential linearity error | All grades | | ± 0.5 | ± 1 | LSB |
| Gain error | $T_A = 25^\circ\text{C}$ | | ± 1 | ± 5 | LSB |
| | $T_A = -55^\circ\text{C}$ to 125°C | | | ± 7 | |
| Gain drift | | | ± 0.1 | | ppm/ $^\circ\text{C}$ |
| Zero code error | $T_A = 25^\circ\text{C}$ | | ± 0.25 | ± 1 | LSB |
| | $T_A = -40^\circ\text{C}$ to 105°C (DAC8831 Only) | | | ± 2.5 | |
| | $T_A = -55^\circ\text{C}$ to 125°C (DAC8831 Only) | | | ± 3 | |
| | $T_A = -55^\circ\text{C}$ to 125°C (DAC8830 Only) | | | ± 2 | |
| Zero code drift | | | ± 0.05 | | ppm/ $^\circ\text{C}$ |
| OUTPUT CHARACTERISTICS | | | | | |
| Voltage output ⁽¹⁾ | | Unipolar operation | 0 | V_{REF} | V |
| | (DAC8831 only) | Bipolar operation | $-V_{REF}$ | V_{REF} | V |
| Output Impedance | | | 6.25 | | k Ω |
| Settling time | To 1/2 LSB of FS, $C_L = 10\text{ pF}$ | | 1 | | μs |
| Slew rate ⁽²⁾ | $C_L = 10\text{ pF}$ | | 25 | | V/ μs |
| Digital-to-analog glitch | 1 LSB change around major carry | | 8 | | nV-s |
| Digital feedthrough ⁽³⁾ | | | 0.2 | | nV-s |
| Output noise | DAC8830 | $T_A = 25^\circ\text{C}$ | 10 | | nV/ $\sqrt{\text{Hz}}$ |
| | DAC8831 | | 18 | | |
| Power supply rejection | V_{DD} varies $\pm 10\%$ | | | ± 1 | LSB |
| Bipolar resistor matching | DAC8831 only | R_{FB} / R_{INV} | 1 | | Ω/Ω |
| | | Ratio error | $\pm 0.0015\%$ | $\pm 0.01\%$ | |
| Bipolar zero error | DAC8831 only | $T_A = 25^\circ\text{C}$ | ± 0.25 | ± 5 | LSB |
| | | $T_A = -55^\circ\text{C}$ to 125°C | | ± 7 | |
| Bipolar zero drift | DAC8831 only | | ± 0.2 | | ppm/ $^\circ\text{C}$ |

(1) The DAC8830 output is unipolar (0 V to V_{REF}). The DAC8831 output is bipolar ($\pm V_{REF}$) when it connects to an external buffer (see the *Bipolar Output Operation* section for details).

(2) Slew Rate is measure from 10% to 90% of transition when the output changes from 0 to full scale.

(3) Digital feedthrough is defined as the impulse injected into the analog output from the digital input. It is measured when the DAC output does not change, \overline{CS} is held high, while SCLK and DIN signals are toggled.

ELECTRICAL CHARACTERISTICS (continued)

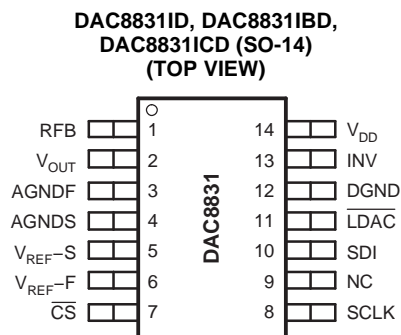
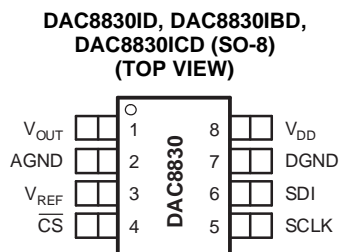
All specifications at $T_A = T_{MIN}$ to T_{MAX} , $V_{DD} = 3\text{ V}$, or $V_{DD} = 5\text{ V}$, $V_{REF} = 2.5\text{ V}$ (unless otherwise noted); specifications subject to change without notice.

| PARAMETER | CONDITIONS | MIN | TYP | MAX | UNIT |
|--|---|------|-----|----------|--------------------|
| REFERENCE INPUT | | | | | |
| Reference input voltage range ⁽⁴⁾ | | 1.25 | | V_{DD} | V |
| Reference input impedance ⁽⁵⁾ | Unipolar mode | 9 | | | k Ω |
| | Bipolar mode, DAC8831 | 7.5 | | | |
| Reference -3-dB bandwidth, BW | Code = FFFFh | | 1.3 | | MHz |
| Reference feedthrough | Code = 0000h, $V_{REF} = 1\text{ V}_{PP}$ at 100 kHz | | 1 | | mV |
| Signal-to-noise ratio, SNR | | | 92 | | dB |
| Reference input capacitance | Code = 0000h | | 75 | | pF |
| | Code = FFFFh | | 120 | | |
| DIGITAL INPUTS | | | | | |
| V_{IL} Input low voltage | $V_{DD} = 2.7\text{ V}$ | | | 0.6 | V |
| | $V_{DD} = 5\text{ V}$ | | | 0.8 | |
| V_{IH} Input high voltage | $V_{DD} = 2.7\text{ V}$ | 2.1 | | | V |
| | $V_{DD} = 5\text{ V}$ | 2.4 | | | |
| Input current | | | | ± 1 | μA |
| Input capacitance | | | | 10 | pF |
| Hysteresis voltage | | | 0.4 | | V |
| POWER SUPPLY | | | | | |
| V_{DD} | | 2.7 | | 5.5 | V |
| I_{DD} | $V_{DD} = 3\text{ V}$ | | 5 | 20 | μA |
| | $V_{DD} = 5\text{ V}$ | | 5 | 20 | |
| Power | $V_{DD} = 3\text{ V}$ | | 15 | 60 | μW |
| | $V_{DD} = 5\text{ V}$ | | 25 | 100 | |
| TEMPERATURE RANGE | | | | | |
| Specified performance | | -55 | | 125 | $^{\circ}\text{C}$ |

(4) Specified by design. V_{ref} production tested only at 2.5 V.

(5) Reference input resistance is code dependent, minimum at 8555h.

PIN CONFIGURATION (NOT TO SCALE)



TERMINAL FUNCTIONS

| TERMINAL NO. | NAME | DESCRIPTION |
|----------------|--------------------|--|
| DAC8830 | | |
| 1 | V _{OUT} | Analog output of DAC |
| 2 | AGND | Analog ground |
| 3 | V _{REF} | Voltage reference input |
| 4 | \overline{CS} | Chip select input (active low). Data is not clocked into SDI unless \overline{CS} is low. |
| 5 | SCLK | Serial clock input |
| 6 | SDI | Serial data input. Data is latched into input register on the rising edge of SCLK. |
| 7 | DGND | Digital ground |
| 8 | VDD | Analog power supply, 3 V to 5 V |
| DAC8831 | | |
| 1 | RFB | Feedback resistor. Connect to the output of external operational amplifier in bipolar mode. |
| 2 | V _{OUT} | Analog output of DAC |
| 3 | AGNDF | Analog ground (Force) |
| 4 | AGNDS | Analog ground (Sense) |
| 5 | V _{REF-S} | Voltage reference input (Sense). Connect to external voltage reference. |
| 6 | V _{REF-F} | Voltage reference input (Force). Connect to external voltage reference. |
| 7 | \overline{CS} | Chip select input (active low). Data is not clocked into SDI unless \overline{CS} is low. |
| 8 | SCLK | Serial clock input |
| 9 | NC | No internal connection |
| 10 | SDI | Serial data input. Data is latched into input register on the rising edge of SCLK. |
| 11 | \overline{LDAC} | Load DAC control input. Active low. When \overline{LDAC} is Low, the DAC latch is simultaneously updated with the content of the input register. |
| 12 | DGND | Digital ground |
| 13 | INV | Junction point of internal scaling resistors. Connect to external operational amplifier's inverting input in bipolar mode. |
| 14 | VDD | Analog power supply, 3 V to 5 V |

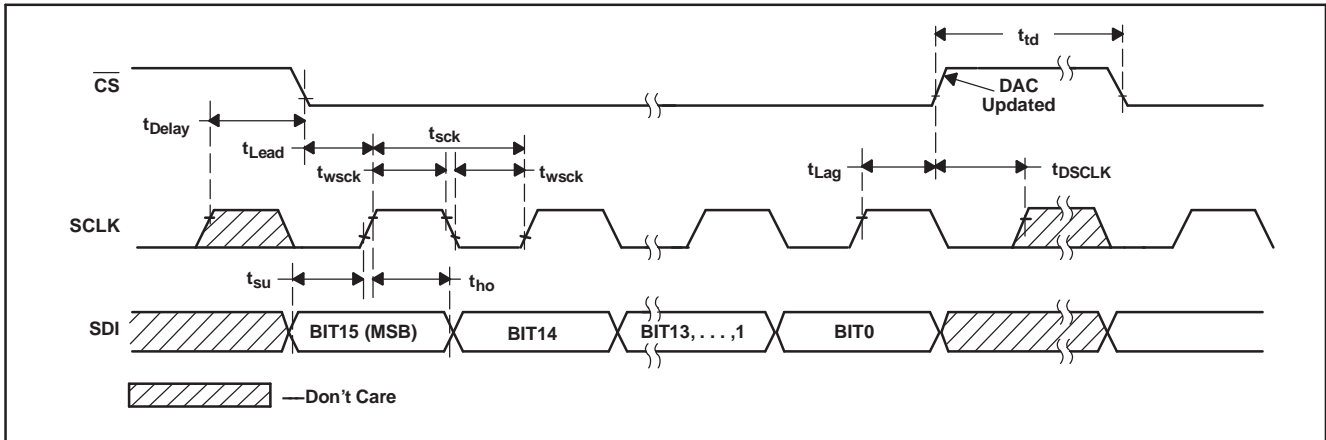


Figure 2. DAC8830 Timing Diagram

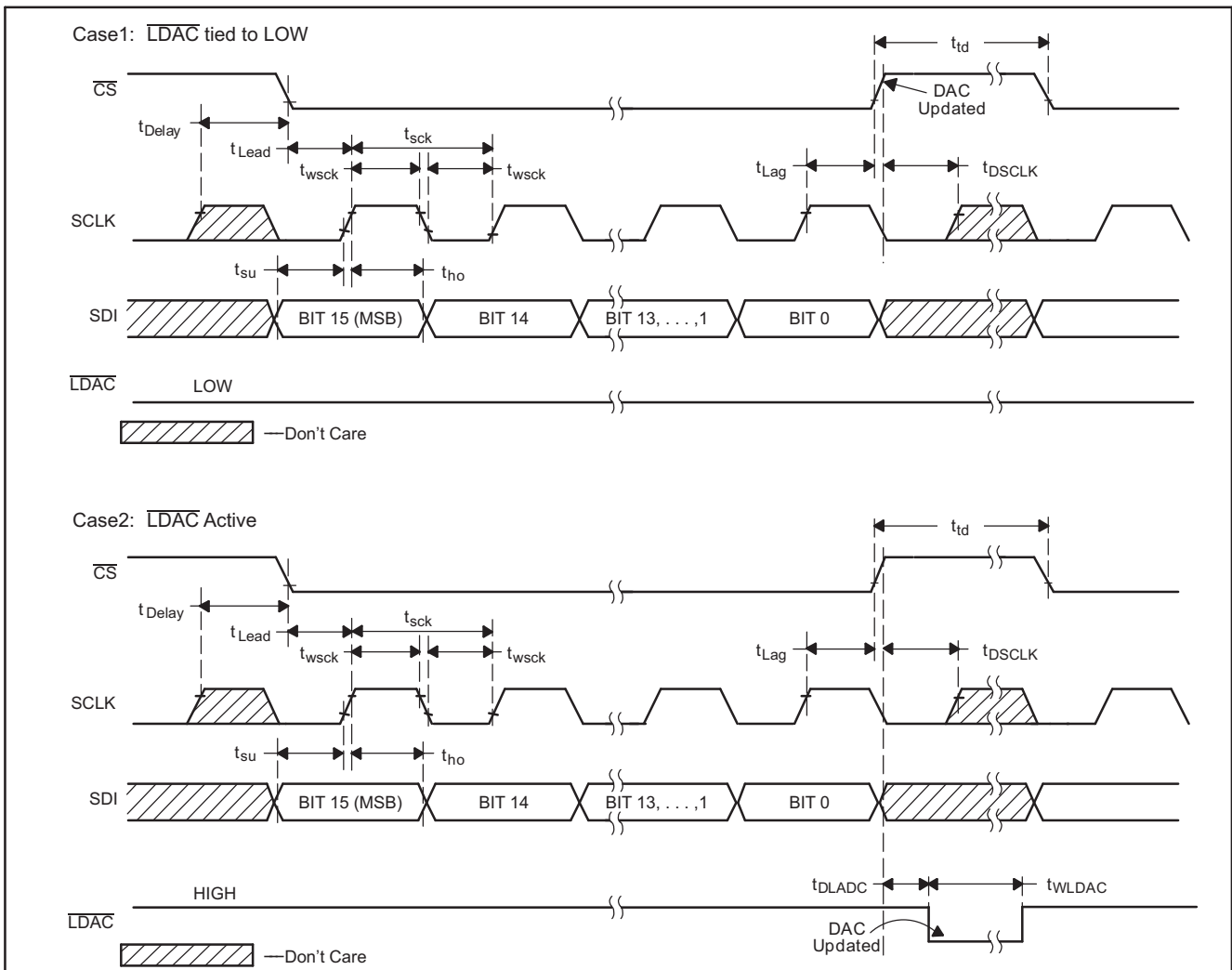


Figure 3. DAC8831 Timing Diagram

TIMING CHARACTERISTICS: $V_{DD} = 5\text{ V}^{(1) (2)}$

 At -55°C to 125°C (unless otherwise noted)

| PARAMETER | | MIN | MAX | UNIT |
|--------------------|--|-----|-----|---------------|
| t_{sck} | SCLK period | 20 | | ns |
| t_{wsck} | SCLK high or low time | 10 | | ns |
| t_{Delay} | Delay from SCLK high to $\overline{\text{CS}}$ low | 18 | | ns |
| t_{Lead} | $\overline{\text{CS}}$ enable lead time | 12 | | ns |
| t_{Lag} | $\overline{\text{CS}}$ enable lag time | 15 | | ns |
| t_{DSCLK} | Delay from $\overline{\text{CS}}$ high to SCLK high | 15 | | ns |
| t_{td} | $\overline{\text{CS}}$ high between active period | 30 | | ns |
| t_{su} | Data setup time (input) | 10 | | ns |
| t_{ho} | Data hold time (input) | 0 | | ns |
| t_{WLDAC} | $\overline{\text{LDAC}}$ width | 30 | | ns |
| t_{DLDAC} | Delay from $\overline{\text{CS}}$ high to $\overline{\text{LDAC}}$ low | 30 | | ns |
| | V_{DD} high to $\overline{\text{CS}}$ low (power-up delay) | 10 | | μs |

(1) Specified by design. Not production tested.

(2) Sample tested during the initial release and after any redesign or process changes that may affect this parameter.

TIMING CHARACTERISTICS: $V_{DD} = 3\text{ V}^{(1) (2)}$

 At -55°C to 125°C (unless otherwise noted)

| PARAMETER | | MIN | MAX | UNIT |
|--------------------|--|-----|-----|---------------|
| t_{sck} | SCLK period | 20 | | ns |
| t_{wsck} | SCLK high or low time | 10 | | ns |
| t_{Delay} | Delay from SCLK high to $\overline{\text{CS}}$ low | 18 | | ns |
| t_{Lead} | $\overline{\text{CS}}$ enable lead time | 15 | | ns |
| t_{Lag} | $\overline{\text{CS}}$ enable lag time | 15 | | ns |
| t_{DSCLK} | Delay from $\overline{\text{CS}}$ high to SCLK high | 15 | | ns |
| t_{td} | $\overline{\text{CS}}$ high between active period | 30 | | ns |
| t_{su} | Data setup time (input) | 10 | | ns |
| t_{ho} | Data hold time (input) | 0 | | ns |
| t_{WLDAC} | $\overline{\text{LDAC}}$ width | 30 | | ns |
| t_{DLDAC} | Delay from $\overline{\text{CS}}$ high to $\overline{\text{LDAC}}$ low | 30 | | ns |
| | V_{DD} high to $\overline{\text{CS}}$ low (power-up delay) | 10 | | μs |

(1) Specified by design. Not production tested.

(2) Sample tested during the initial release and after any redesign or process changes that may affect this parameter.

TYPICAL CHARACTERISTICS: $V_{DD} = 5\text{ V}$

At $T_A = 25^\circ\text{C}$, $V_{REF} = 2.5\text{ V}$ (unless otherwise noted)

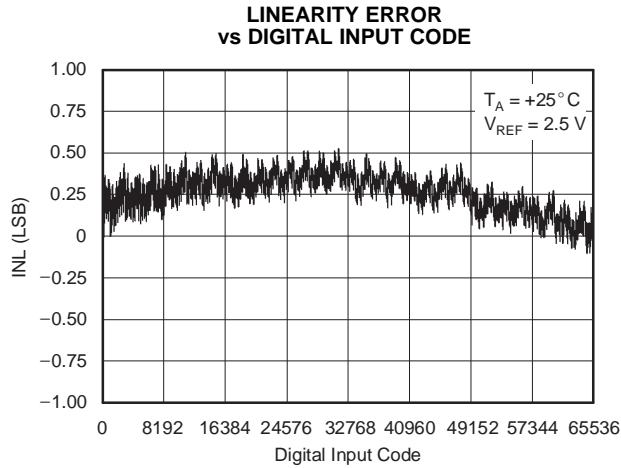


Figure 4.

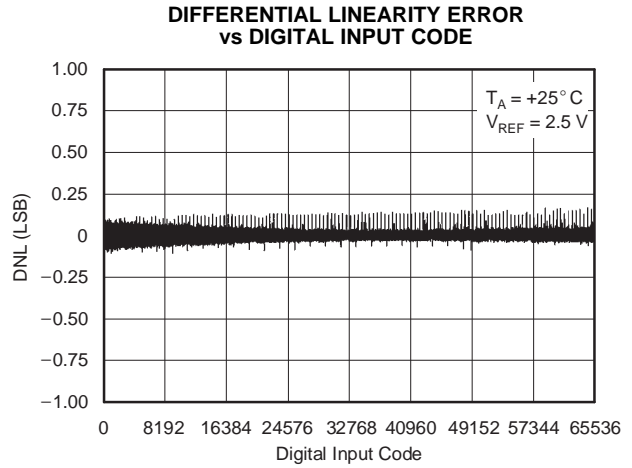


Figure 5.

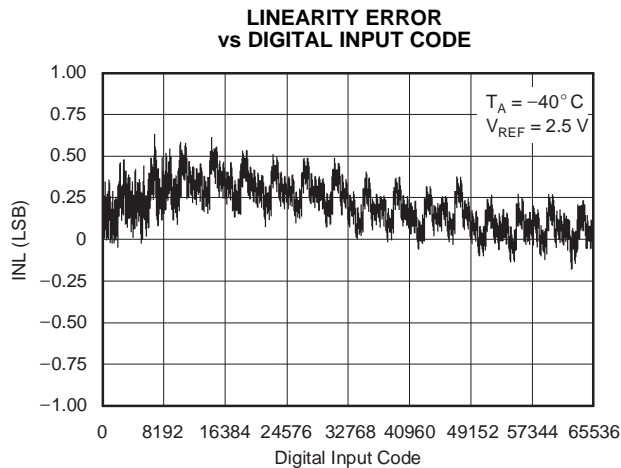


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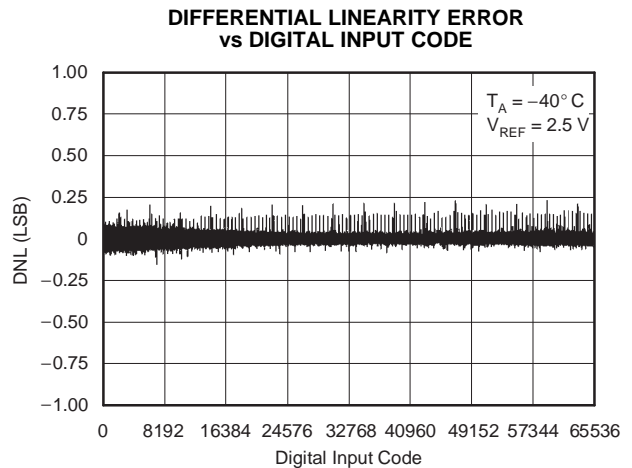


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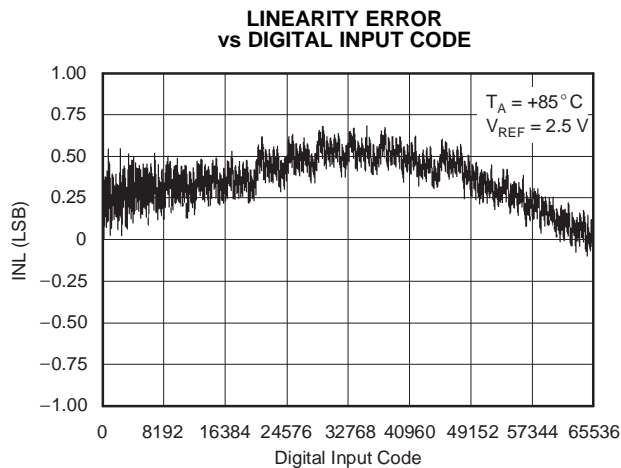


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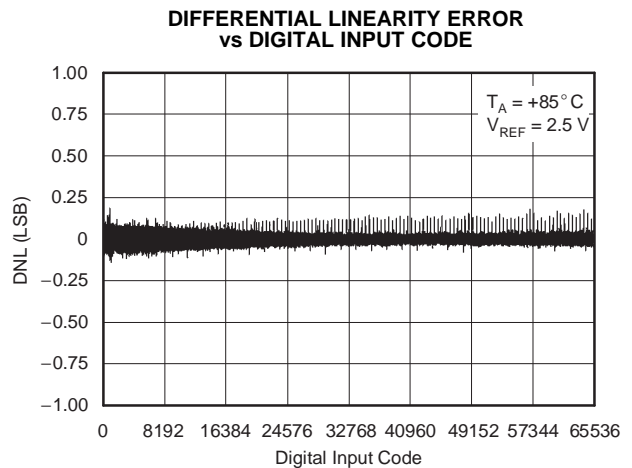


Figure 9.

TYPICAL CHARACTERISTICS: $V_{DD} = 5\text{ V}$ (continued)

At $T_A = 25^\circ\text{C}$, $V_{REF} = 2.5\text{ V}$ (unless otherwise noted)

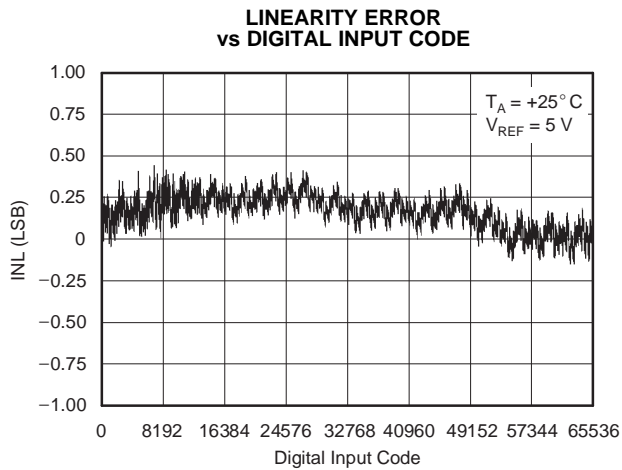


Figure 10.

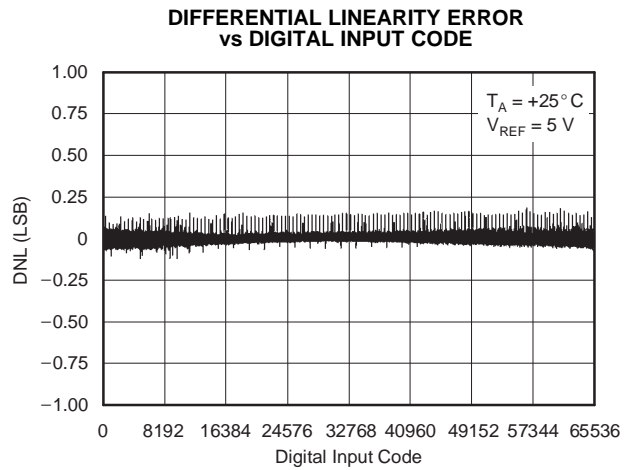


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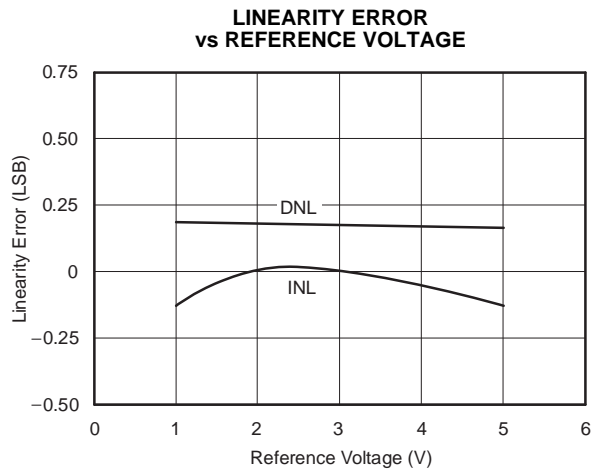


Figure 12.

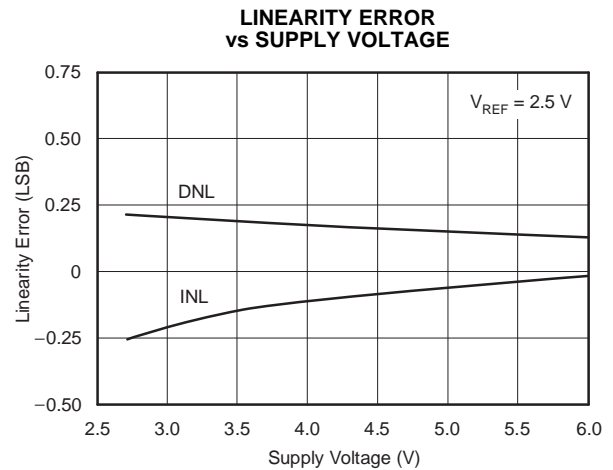


Figure 13.

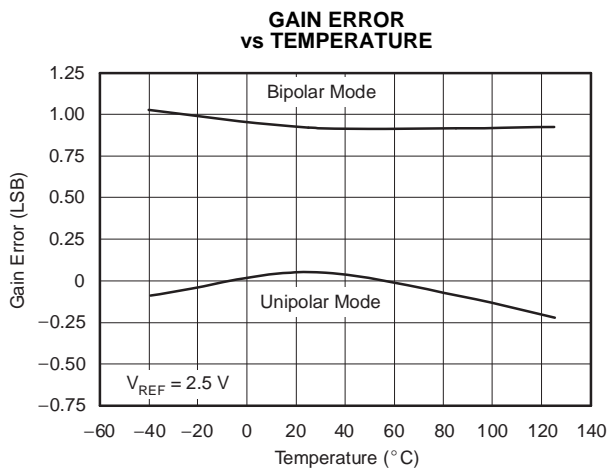


Figure 14.

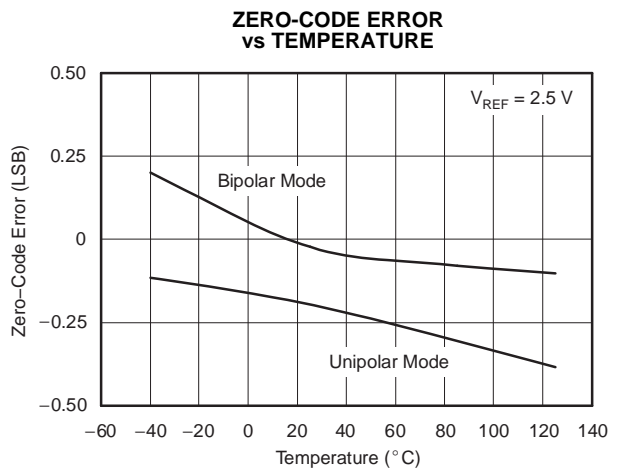


Figure 15.

TYPICAL CHARACTERISTICS: $V_{DD} = 5\text{ V}$ (continued)

At $T_A = 25^\circ\text{C}$, $V_{REF} = 2.5\text{ V}$ (unless otherwise noted)

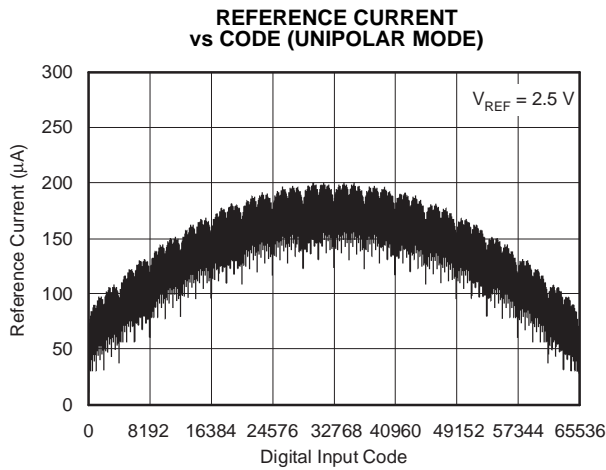


Figure 16.

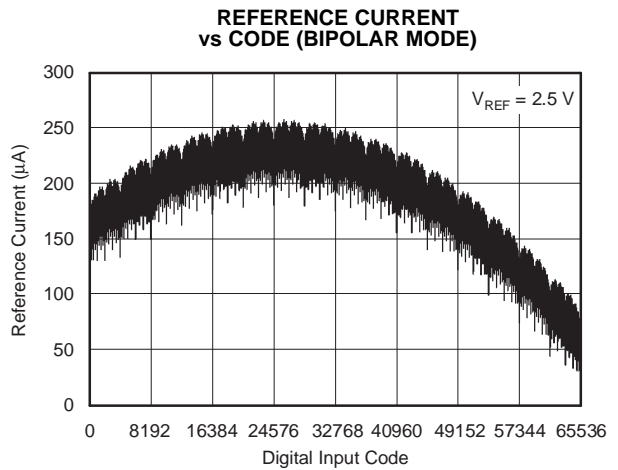


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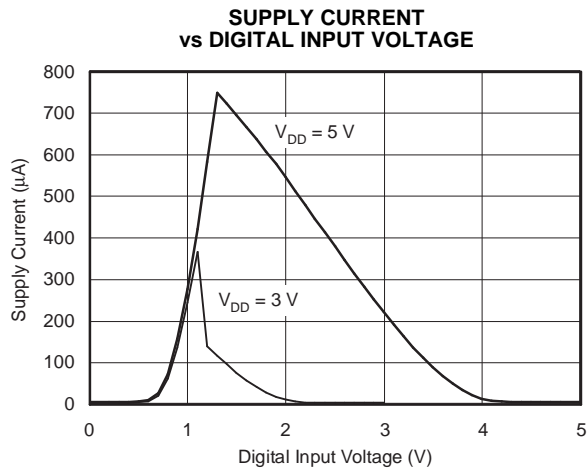


Figure 18.

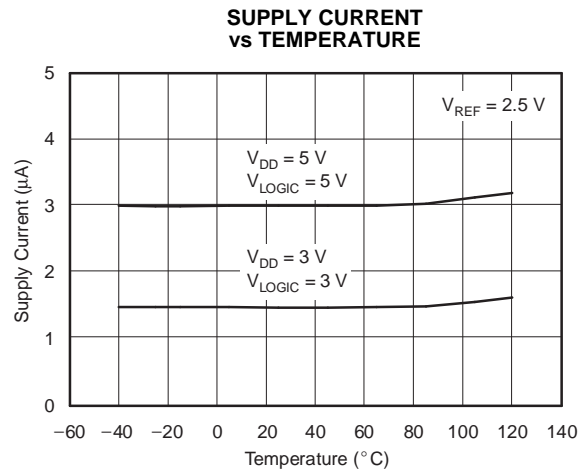


Figure 19.

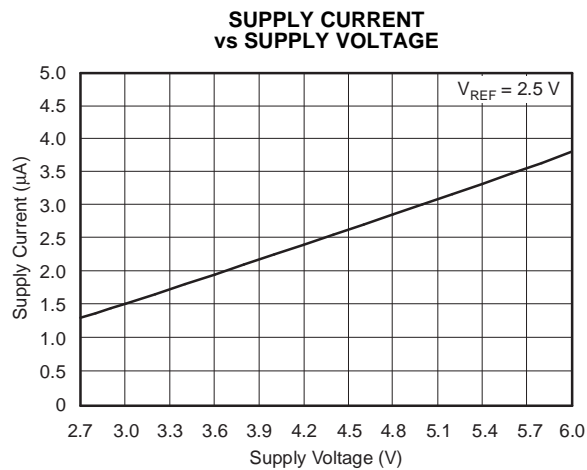


Figure 20.

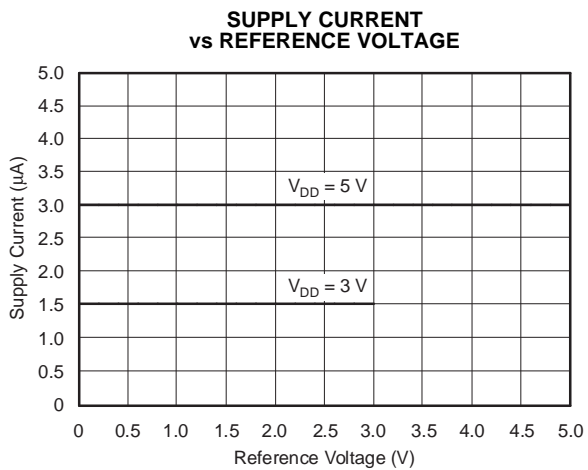
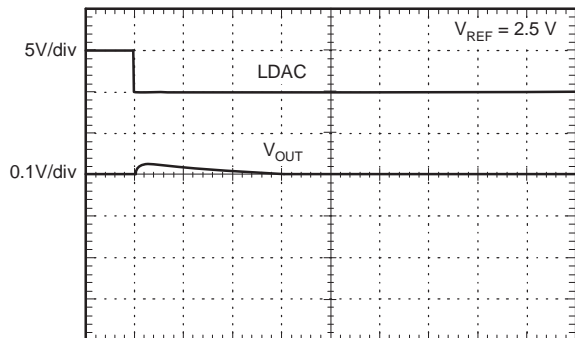


Figure 21.

TYPICAL CHARACTERISTICS: $V_{DD} = 5\text{ V}$ (continued)

At $T_A = 25^\circ\text{C}$, $V_{REF} = 2.5\text{ V}$ (unless otherwise noted)

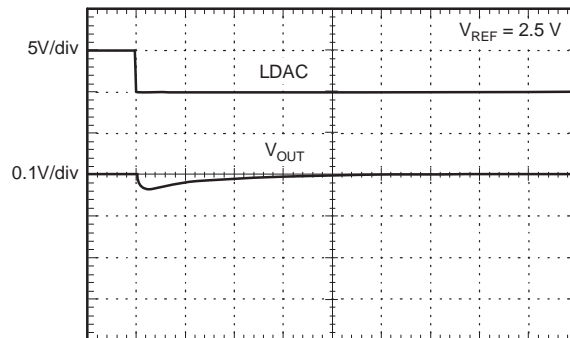
MAJOR-CARRY GLITCH
(FALLING)



Time (0.5 μs /div)

Figure 22.

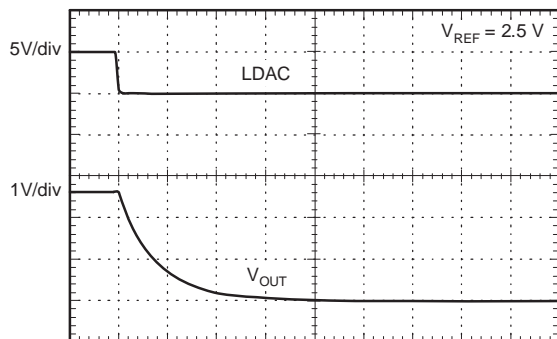
MAJOR-CARRY GLITCH
(RISING)



Time (0.5 μs /div)

Figure 23.

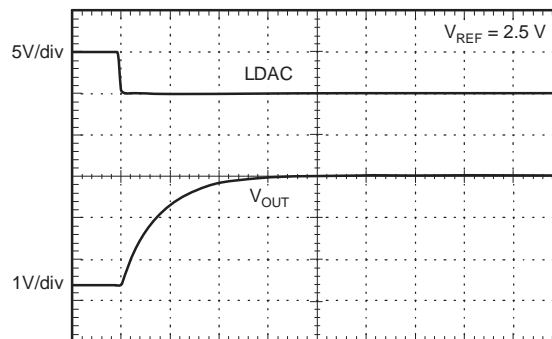
DAC SETTling TIME
(FALLING)



Time (0.2 μs /div)

Figure 24.

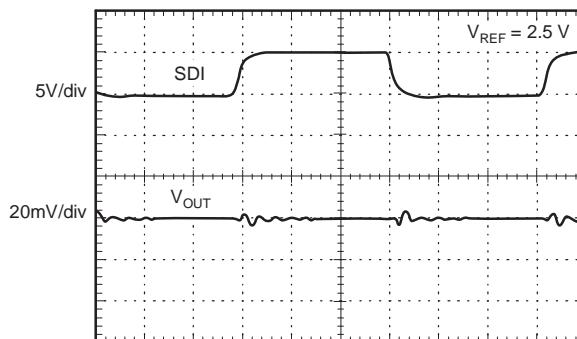
DAC SETTling TIME
(RISING)



Time (0.2 μs /div)

Figure 25.

DIGITAL
FEEDTHROUGH



Time (50ns/div)

Figure 26.

TYPICAL CHARACTERISTICS: $V_{DD} = 3\text{ V}$

At $T_A = 25^\circ\text{C}$, $V_{REF} = 2.5\text{ V}$ (unless otherwise noted)

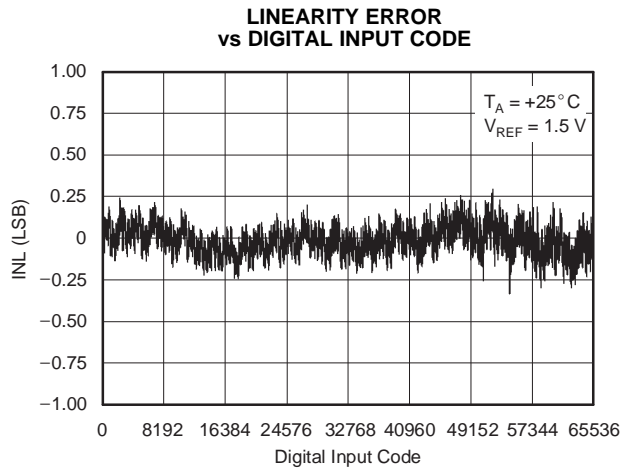


Figure 27.

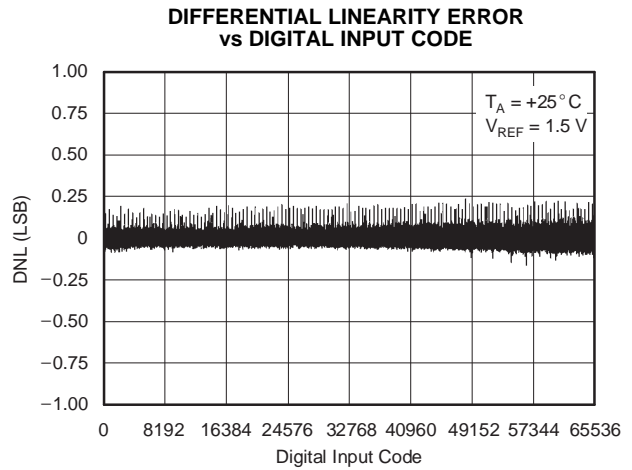


Figure 28.

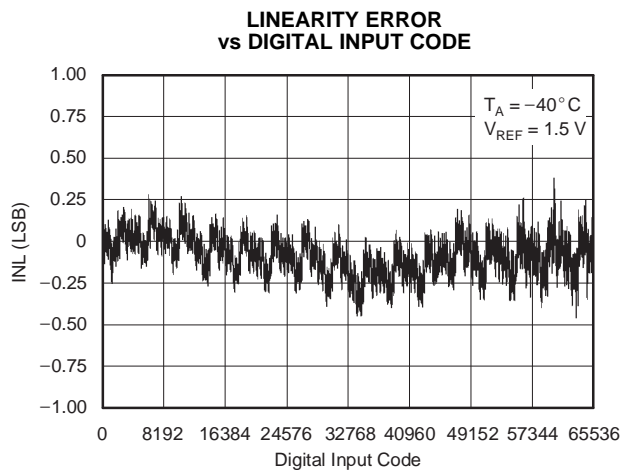


Figure 29.

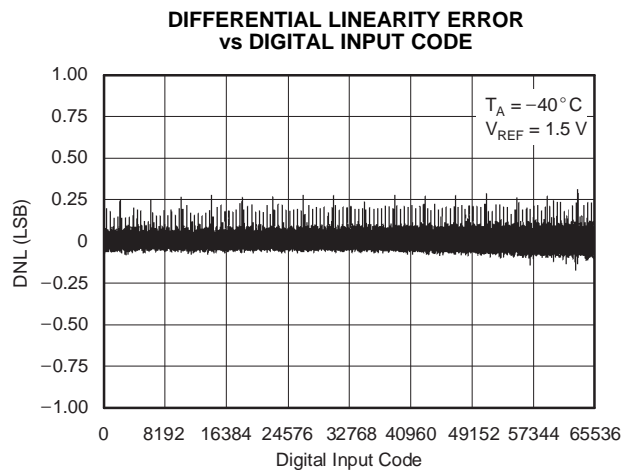


Figure 30.

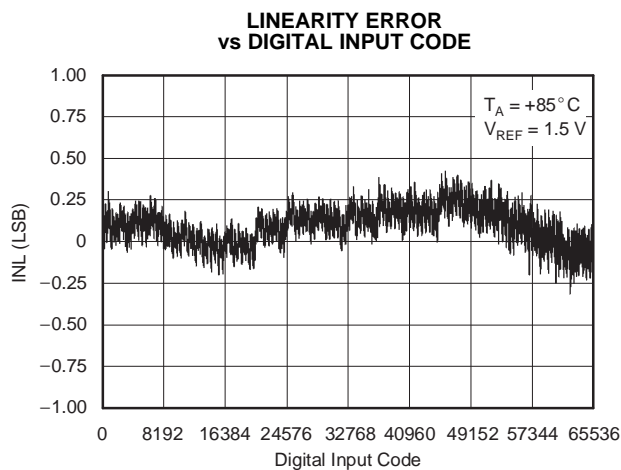


Figure 31.

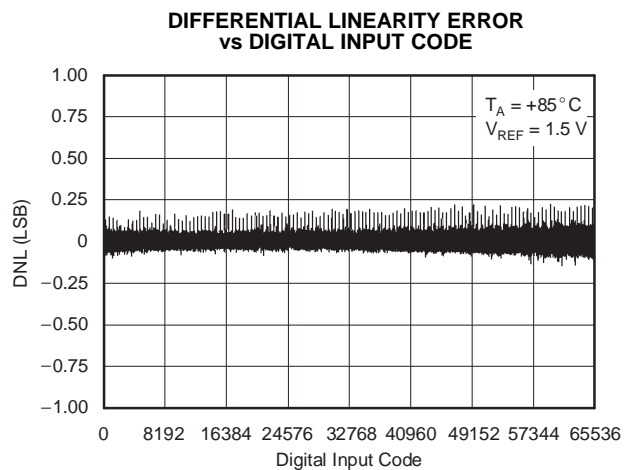


Figure 32.

TYPICAL CHARACTERISTICS: $V_{DD} = 3\text{ V}$ (continued)

At $T_A = 25^\circ\text{C}$, $V_{REF} = 2.5\text{ V}$ (unless otherwise noted)

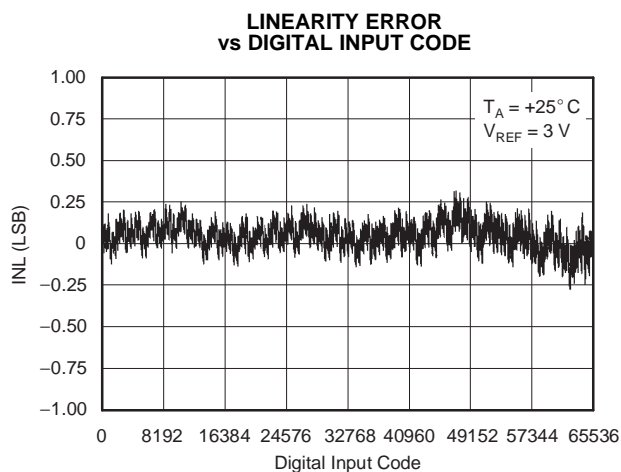


Figure 33.

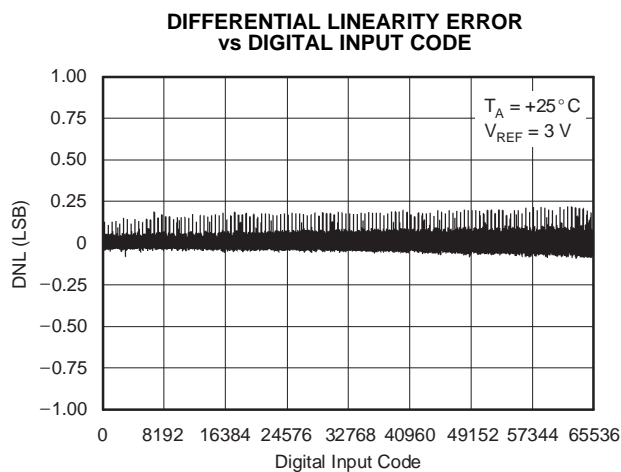


Figure 34.

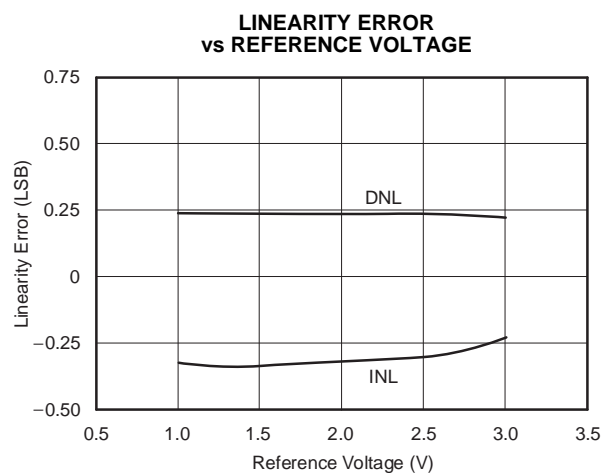


Figure 35.

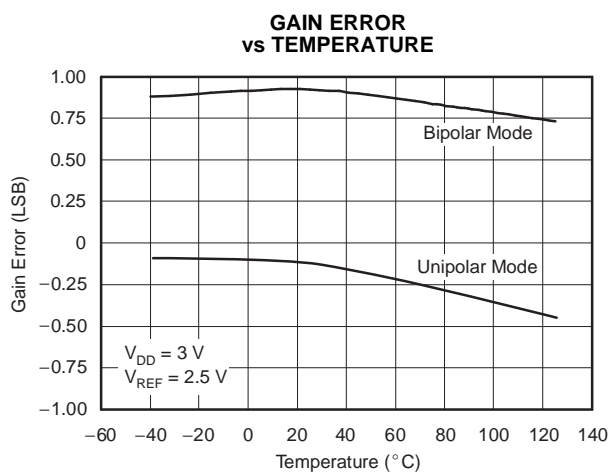


Figure 36.

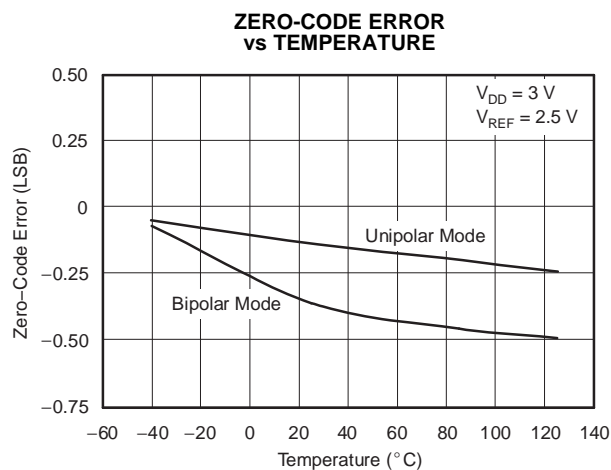


Figure 37.

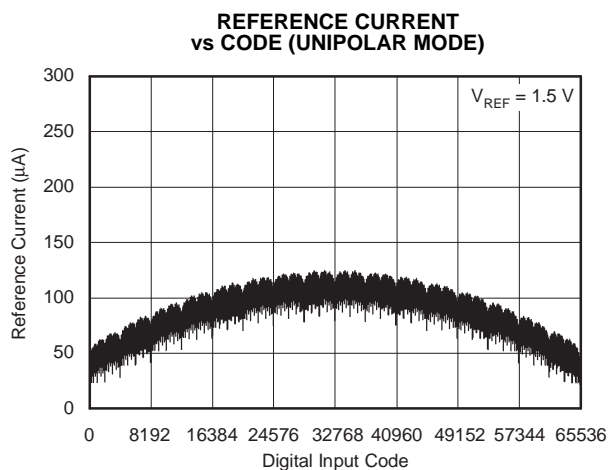


Figure 38.

TYPICAL CHARACTERISTICS: $V_{DD} = 3\text{ V}$ (continued)

At $T_A = 25^\circ\text{C}$, $V_{REF} = 2.5\text{ V}$ (unless otherwise noted)

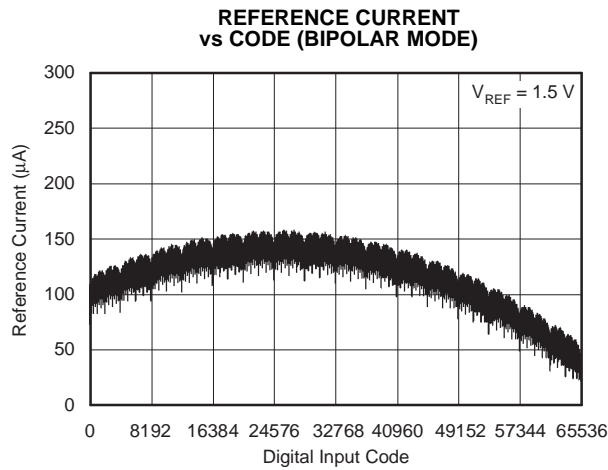


Figure 39.

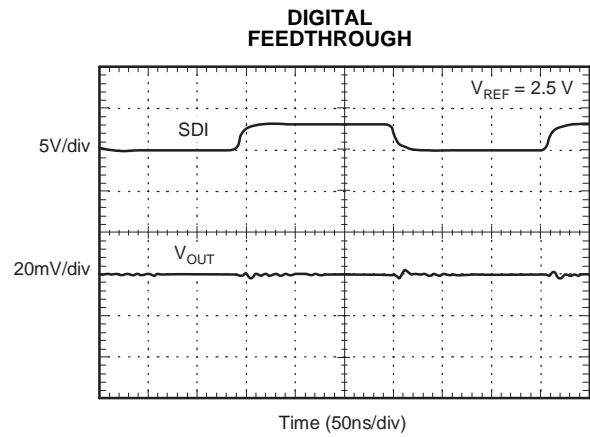


Figure 40.

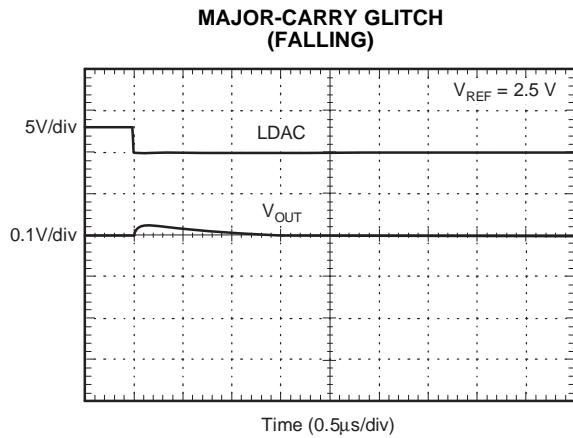


Figure 41.

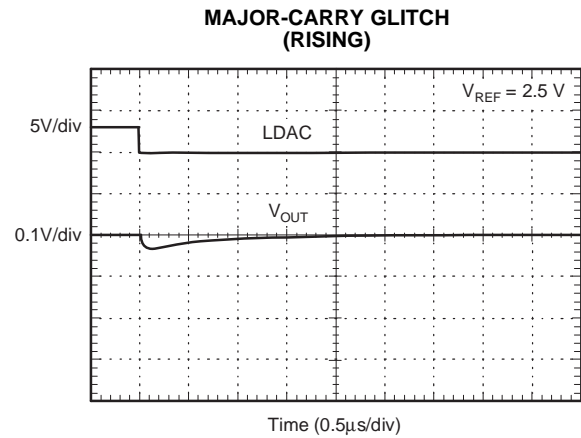


Figure 42.

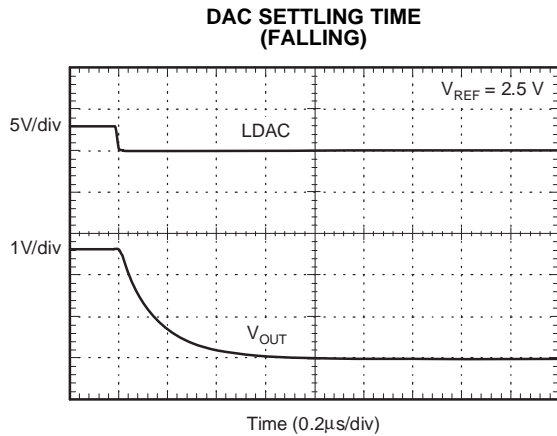


Figure 43.

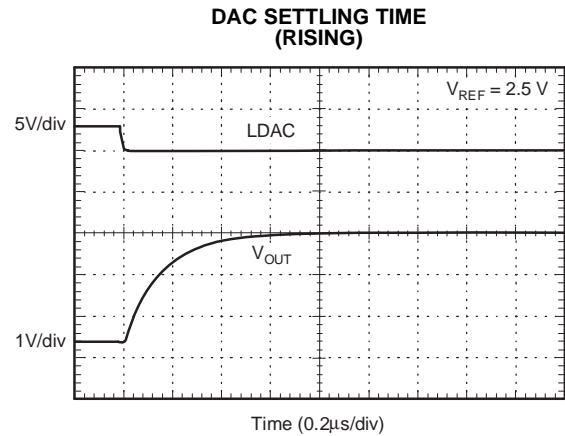


Figure 44.

THEORY OF OPERATION

General Description

The DAC8830 and DAC8831 are single, 16-bit, serial-input, voltage-output DACs. They operate from a single supply ranging from 2.7 V to 5 V, and typically consume 5 μ A. Data is written to these devices in a 16-bit word format, via an SPI serial interface. To ensure a known power-up state, these parts were designed with a power-on reset function. The DAC8830 and DAC8831 are reset to zero code. In unipolar mode, the DAC8830 and DAC8831 are reset to 0V, and in bipolar mode, the DAC8831 is reset to $-V_{REF}$. Kelvin sense connections for the reference and analog ground are included on the DAC8831.

Digital-to-Analog Sections

The DAC architecture for both devices consists of two matched DAC sections and is segmented. A simplified circuit diagram is shown in Figure 45. The four MSBs of the 16-bit data word are decoded to drive 15 switches, E1 to E15. Each of these switches connects one of 15 matched resistors to either AGND or V_{REF} . The remaining 12 bits of the data word drive switches S0 to S11 of a 12-bit voltage mode R-2R ladder network.

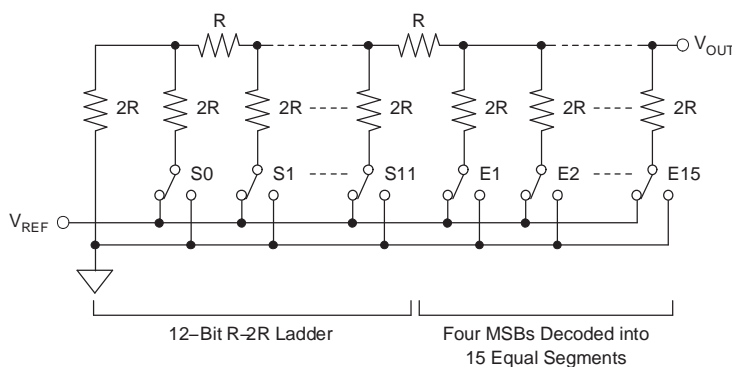


Figure 45. DAC Architecture

Output Range

The output of the DAC is

$$V_{OUT} = (V_{REF} \times \text{Code}/65536)$$

Where:

Code = Decimal data word loaded to the DAC latch

THEORY OF OPERATION (continued)

Power-on Reset

Both devices have a power-on reset function to ensure the output is at a known state upon power up. In the DAC8830 and DAC8831, on power up, the DAC latch and input registers contain all 0s until new data is loaded from the input serial shift register. Therefore, after power up, the output from pin V_{OUT} of the DAC8830 is 0 V. The output from pin V_{OUT} of the DAC8831 is 0 V in unipolar mode and $-V_{REF}$ in bipolar mode.

However, the serial register of the DAC8830 and DAC8831 is not cleared on power up, so its contents are undefined. When loading data initially to the device, 16 bits or more should be loaded to prevent erroneous data appearing on the output. If more than 16 bits are loaded, the last 16 are kept; if less than 16 are loaded, bits will remain from the previous word. If the device must be interfaced with data shorter than 16 bits, the data should be padded with 0s at the LSBs.

Serial Interface

The digital interface is standard 3-wire connection compatible with SPI, QSPI, Microwire, and Texas Instruments DSP interfaces, which can operate at speeds up to 50 Mbps. The data transfer is framed by \overline{CS} , the chip select signal. The DAC works as a bus slave. The bus master generates the synchronize clock, SCLK, and initiates the transmission. When \overline{CS} is high, the DAC is not accessed, and the clock SCLK and serial input data SDI are ignored. The bus master accesses the DAC by driving pin \overline{CS} low. Immediately following the high-to-low transition of \overline{CS} , the serial input data on pin SDI is shifted out from the bus master synchronously on the falling edge of SCLK, and latched on the rising edge of SCLK into the input shift register, MSB first. The low-to-high transition of \overline{CS} transfers the contents of the input shift register to the input register. All data registers are 16 bit. It takes 16 clocks of SCLK to transfer one data word to the parts. To complete a whole data word, \overline{CS} must go high immediately after 16 SCLKs are clocked in. If more than 16 SCLKs are applied during the low state of \overline{CS} , the last 16 bits are transferred to the input register on the rising edge of \overline{CS} . However, if \overline{CS} is not kept low during the entire 16 SCLK cycles, data is corrupted. In this case, reload the DAC latch with a new 16-bit word.

In the DAC8830, the contents of the input register are transferred into the DAC latch immediately when the input register is loaded, and the DAC output is updated at the same time.

The DAC8831 has an \overline{LDAC} pin allowing the DAC latch to be updated asynchronously by bringing \overline{LDAC} low after \overline{CS} goes high. In this case, \overline{LDAC} must be maintained high while \overline{CS} is low. If \overline{LDAC} is tied permanently low, the DAC latch is updated immediately after the input register is loaded (caused by the low-to-high transition of \overline{CS}).

APPLICATION INFORMATION

Unipolar Output Operation

These DACs are capable of driving unbuffered loads of 60 kΩ. Unbuffered operation results in low supply current (typically 5 μA) and a low offset error. The DAC8830 provides a unipolar output swing ranging from 0 V to V_{REF} . The DAC8831 can be configured to output both unipolar and bipolar voltages. Figure 46 and Figure 47 show a typical unipolar output voltage circuit for each device, respectively. The code table for this mode of operation is shown in Table 1.

Table 1. Unipolar Code

| DAC Latch Contents | | Analog Output |
|--------------------|----------------|--|
| MSB | LSB | |
| 1111 | 1111 1111 1111 | $V_{REF} \times (65,535/65,536)$ |
| 1000 | 0000 0000 0000 | $V_{REF} \times (32,768/65,536) = V_{REF}$ |
| 0000 | 0000 0000 0001 | $V_{REF} \times (1/65,536)$ |
| 0000 | 0000 0000 0000 | 0 V |

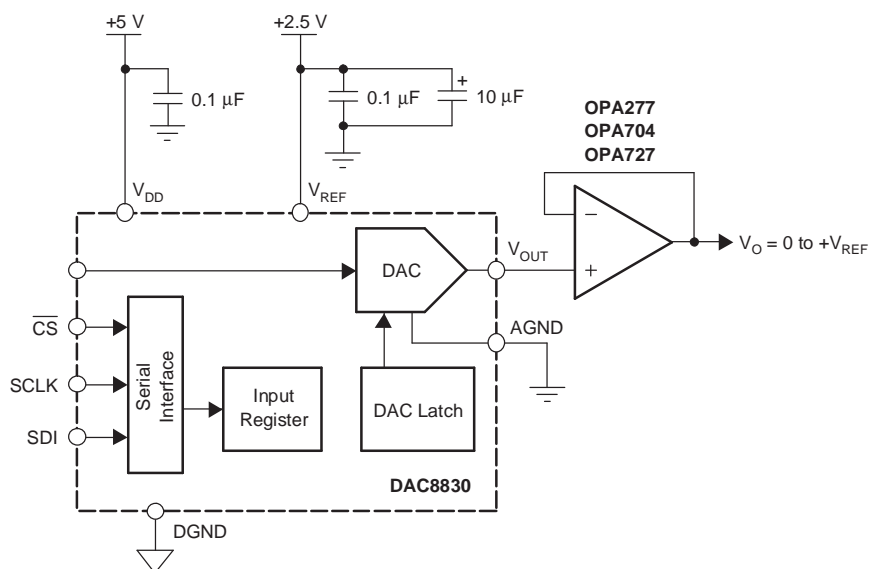


Figure 46. Unipolar Output Mode of DAC8830

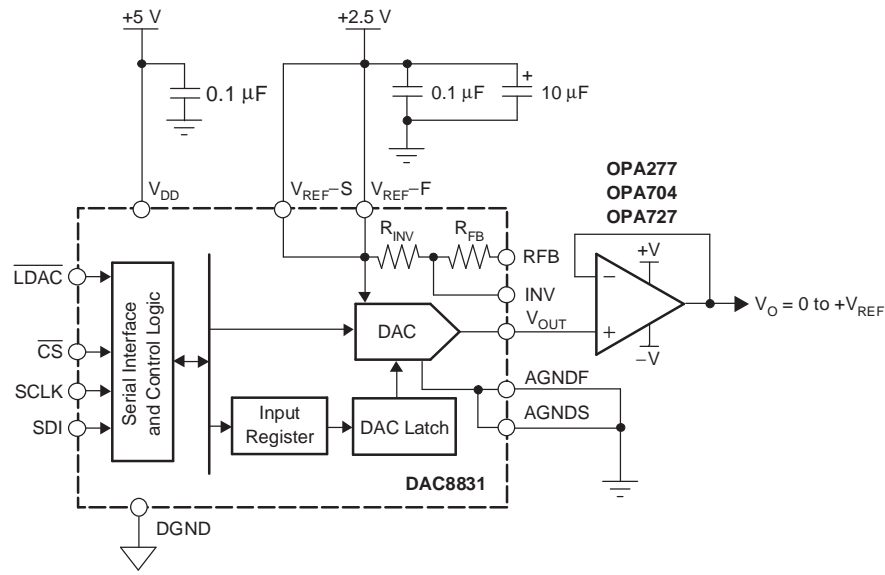


Figure 47. Unipolar Output Mode of DAC8831

Assuming a perfect reference, the worst-case output voltage may be calculated from the following equation:

Unipolar Mode Worst-Case Output

$$V_{OUT_UNI} = \frac{D}{2^{16}} \times (V_{REF} + V_{GE}) + V_{ZSE} + INL$$

Where:

- V_{OUT_UNI} = Unipolar mode worst-case output
- D = Code loaded to DAC
- V_{REF} = Reference voltage applied to part
- V_{GE} = Gain error in volts
- V_{ZSE} = Zero scale error in volts
- INL = Integral nonlinearity in volts

Bipolar Output Operation

With the aid of an external operational amplifier, the DAC8831 may be configured to provide a bipolar voltage output. A typical circuit of such an operation is shown in Figure 48. The matched bipolar offset resistors R_{FB} and R_{INV} are connected to an external operational amplifier to achieve this bipolar output swing; typically, $R_{FB} = R_{INV} = 28\text{ k}\Omega$.

Table 2 shows the transfer function for this output operating mode. The DAC8831 also provides a set of Kelvin connections to the analog ground and external reference inputs.

Table 2. Bipolar Code

| DAC Latch Contents | | Analog Output |
|--------------------|----------------|--|
| MSB | LSB | |
| 1111 | 1111 1111 1111 | $V_{REF} \times (32,767/32,768)$ |
| 1000 | 0000 0000 0000 | $V_{REF} \times (1/32,768)$ |
| 0111 | 1111 1111 1111 | 0 V |
| 0000 | 0000 0000 0001 | $-V_{REF} \times (1/32,768)$ |
| 0000 | 0000 0000 0000 | $-V_{REF} \times (32,767/32,768) = -V_{REF}$ |

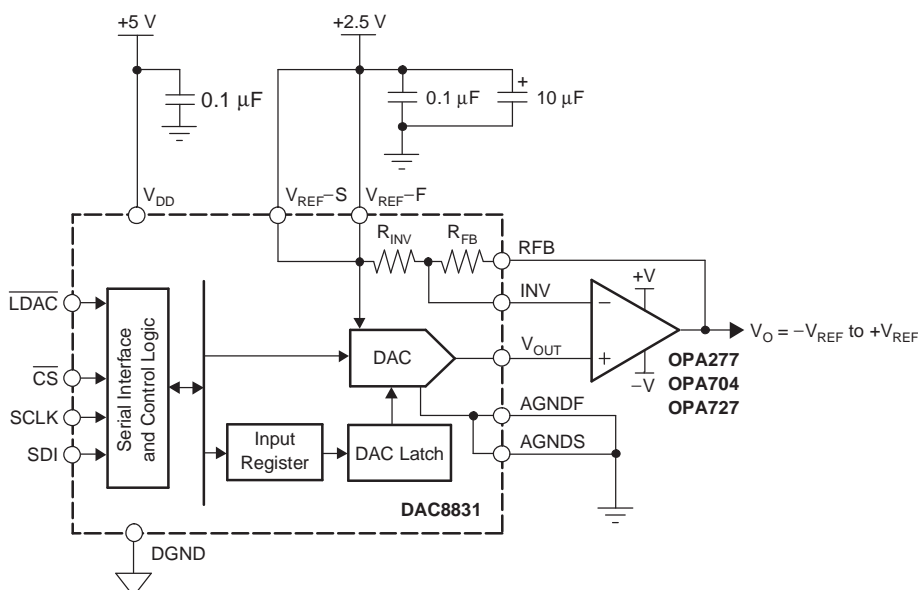


Figure 48. Bipolar Output Mode of DAC8831

Assuming a perfect reference, the worst-case output voltage may be calculated from the following equation:

Bipolar Mode Worst-Case Output

$$V_{OUT_BIP} = \frac{\left[(V_{OUT_UNI} + V_{OS}) (2 + RD) - V_{REF} (1 + RD) \right]}{1 + \left(\frac{2 + RD}{A} \right)}$$

Where:

V_{OS} = External operational amplifier input offset voltage

$RD = R_{FB}$ and R_{IN} resistor matching error

A = Operational amplifier open-loop gain

Output Amplifier Selection

For bipolar mode, a precision amplifier should be used, supplied from a dual power supply. This provides the $\pm V_{REF}$ output.

In a single-supply application, selection of a suitable operational amplifier may be more difficult because the output swing of the amplifier does not usually include the negative rail; in this case, AGND. This output swing can result in some degradation of the specified performance unless the application does not use codes near 0.

The selected operational amplifier needs to have low-offset voltage (the DAC LSB is 38 μ V with a 2.5-V reference), eliminating the need for output offset trims. Input bias current should also be low because the bias current multiplied by the DAC output impedance (approximately 6.25 k Ω) adds to the zero-code error.

Rail-to-rail input and output performance is required. For fast settling, the slew rate of the operational amplifier should not impede the settling time of the DAC. Output impedance of the DAC is constant and code-independent, but in order to minimize gain errors the input impedance of the output amplifier should be as high as possible. The amplifier should also have a 3 dB bandwidth of 1 MHz or greater. The amplifier adds another time constant to the system, thus increasing the settling time of the output. A higher 3-dB amplifier bandwidth results in a shorter effective settling time of the combined DAC and amplifier.

Reference and Ground

Since the input impedance is code-dependent, the reference pin should be driven from a low impedance source. The DAC8830 and DAC8831 operate with a voltage reference ranging from 1.25 V to V_{DD} . References below 1.25 V result in reduced accuracy.

The DAC full-scale output voltage is determined by the reference. [Table 1](#) and [Table 2](#) outline the analog output voltage for particular digital codes.

For optimum performance, Kelvin sense connections are provided on the DAC8831. If the application does not require separate force and sense lines, they should be tied together close to the package to minimize voltage drops between the package leads and the internal die.

Power Supply and Reference Bypassing

For accurate high-resolution performance, it is recommended that the reference and supply pins be bypassed with a 10 μ F tantalum capacitor in parallel with a 0.1 μ F ceramic capacitor.

CROSS REFERENCE

The DAC8830 and DAC8831 have an industry-standard pinout configuration (see [Table 3](#)).

Table 3. Cross Reference

| MODEL | INL (LSB) | DNL (LSB) | POWER-ON RESET TO | TEMPERATURE RANGE | PACKAGE DESCRIPTION | PACKAGE OPTION | CROSS REFERENCE |
|------------|-----------|-----------|-------------------|-------------------|--------------------------|----------------|-------------------------|
| DAC8830ICD | ±1 | ±1 | Zero-Code | –40°C to 85°C | 8-Lead Small Outline IC | SO-8 | AD5541CR, MAX541AESA |
| DAC8830IBD | ±2 | ±1 | Zero-Code | –40°C to 85°C | 8-Lead Small Outline IC | SO-8 | AD5541BR, MAX541BESA |
| DAC8830ID | ±4 | ±1 | Zero-Code | –40°C to 85°C | 8-Lead Small Outline IC | SO-8 | AD5541AR, MAX541CESA |
| DAC8830MCD | ±1 | ±1 | Zero-Code | –55°C to 125°C | 8-Lead Small Outline IC | SO-8 | N/A |
| N/A | ±1 | ±1 | Zero-Code | –40°C to 85°C | 8-Lead Plastic DIP | PDIP-8 | MAX541AEP A |
| N/A | ±2 | ±1 | Zero-Code | –40°C to 85°C | 8-Lead Plastic DIP | PDIP-8 | MAX541BEP A |
| N/A | ±4 | ±1 | Zero-Code | –40°C to 85°C | 8-Lead Plastic DIP | PDIP-8 | MAX541CEP A |
| N/A | ±1 | ±1 | Zero-Code | 0°C to 70°C | 8-Lead Small Outline IC | SO-8 | AD5541LR |
| N/A | ±2 | ±1.5 | Zero-Code | 0°C to 70°C | 8-Lead Small Outline IC | SO-8 | AD5541JR |
| N/A | ±1 | ±1 | Zero-Code | 0°C to 70°C | 8-Lead Plastic DIP | PDIP-8 | MAX541AEP A |
| N/A | ±2 | ±1 | Zero-Code | 0°C to 70°C | 8-Lead Plastic DIP | PDIP-8 | MAX541BEP A |
| N/A | ±4 | ±1 | Zero-Code | 0°C to 70°C | 8-Lead Plastic DIP | PDIP-8 | MAX541CEP A |
| DAC8831ICD | ±1 | ±1 | Zero-Code | –40°C to 85°C | 14-Lead Small Outline IC | SO-14 | AD5542CR, MAX542AESD |
| DAC8831IBD | ±2 | ±1 | Zero-Code | –40°C to 85°C | 14-Lead Small Outline IC | SO-14 | AD5542BR, MAX542BESD |
| DAC8831ID | ±4 | ±1 | Zero-Code | –40°C to 85°C | 14-Lead Small Outline IC | SO-14 | AD5542AR, MAX542CESD |
| DAC8831MCD | ±1 | ±1 | Zero-Code | –55°C to 125°C | 14-Lead Small Outline IC | SO-14 | N/A |
| N/A | ±1 | ±1 | Zero-Code | –40°C to 85°C | 14-Lead Plastic DIP | PDIP-14 | MAX542ACPD |
| N/A | ±2 | ±1 | Zero-Code | –40°C to 85°C | 14-Lead Plastic DIP | PDIP-14 | MAX542BCPD |
| N/A | ±4 | ±1 | Zero-Code | –40°C to 85°C | 14-Lead Plastic DIP | PDIP-14 | MAX542CCPD |
| N/A | ±4 | ±1 | Zero-Code | –55°C to 125°C | 14-Lead Ceramic SB | SB-14 | MAX542CMJD |
| N/A | ±1 | ±1 | Zero-Code | 0°C to 70°C | 14-Lead Small Outline IC | SO-14 | AD5542LR |
| N/A | ±2 | ±1.5 | Zero-Code | 0°C to 70°C | 14-Lead Small Outline IC | SO-14 | AD5542JR |
| N/A | ±1 | ±1 | Zero-Code | 0°C to 70°C | 14-Lead Small Outline IC | SO-14 | MAX542AEPD |
| N/A | ±2 | ±1 | Zero-Code | 0°C to 70°C | 14-Lead Small Outline IC | SO-14 | MAX542BEPD |
| N/A | ±4 | ±1 | Zero-Code | 0°C to 70°C | 14-Lead Small Outline IC | SO-14 | MAX542CEPD |

PACKAGING INFORMATION

| Orderable Device | Status ⁽¹⁾ | Package Type | Package Drawing | Pins | Package Qty | Eco Plan ⁽²⁾ | Lead/Ball Finish | MSL Peak Temp ⁽³⁾ |
|------------------|-----------------------|--------------|-----------------|------|-------------|-------------------------|------------------|------------------------------|
| DAC8830MCDEP | ACTIVE | SOIC | D | 8 | 75 | Green (RoHS & no Sb/Br) | CU NIPDAU | Level-3-260C-168 HR |
| DAC8830MCDREP | ACTIVE | SOIC | D | 8 | 2500 | Green (RoHS & no Sb/Br) | CU NIPDAU | Level-3-260C-168 HR |
| DAC8831MCDEP | ACTIVE | SOIC | D | 14 | 50 | Green (RoHS & no Sb/Br) | CU NIPDAU | Level-3-260C-168 HR |
| DAC8831MCDREP | ACTIVE | SOIC | D | 14 | 2500 | Green (RoHS & no Sb/Br) | CU NIPDAU | Level-3-260C-168 HR |
| V62/06671-01XE | ACTIVE | SOIC | D | 8 | 2500 | Green (RoHS & no Sb/Br) | CU NIPDAU | Level-3-260C-168 HR |
| V62/06671-02XE | ACTIVE | SOIC | D | 8 | 75 | Green (RoHS & no Sb/Br) | CU NIPDAU | Level-3-260C-168 HR |
| V62/06671-03YE | ACTIVE | SOIC | D | 14 | 2500 | Green (RoHS & no Sb/Br) | CU NIPDAU | Level-3-260C-168 HR |
| V62/06671-04YE | ACTIVE | SOIC | D | 14 | 50 | Green (RoHS & no Sb/Br) | CU NIPDAU | Level-3-260C-168 HR |

⁽¹⁾ The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

⁽²⁾ Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check <http://www.ti.com/productcontent> for the latest availability information and additional product content details.

TBD: The Pb-Free/Green conversion plan has not been defined.

Pb-Free (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

Pb-Free (RoHS Exempt): This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

⁽³⁾ MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

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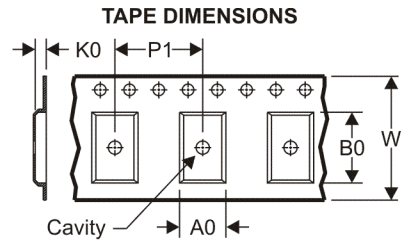
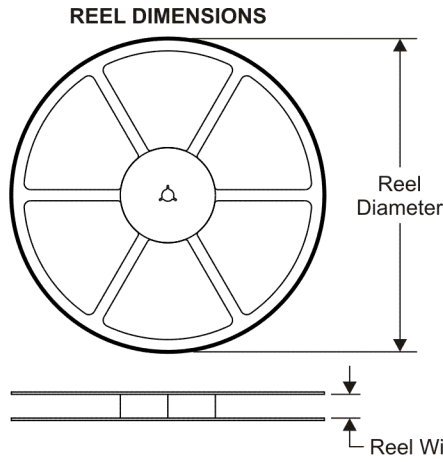
OTHER QUALIFIED VERSIONS OF DAC8830-EP, DAC8831-EP :

- Catalog: [DAC8830](#), [DAC8831](#)

NOTE: Qualified Version Definitions:

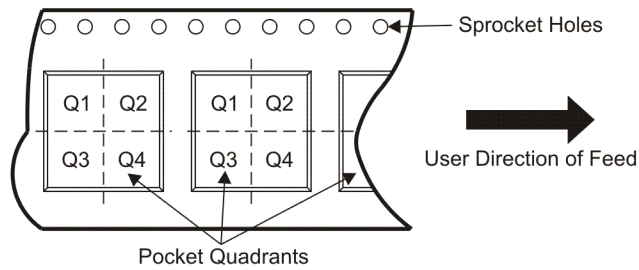
- Catalog - TI's standard catalog product

TAPE AND REEL INFORMATION



| | |
|----|---|
| A0 | Dimension designed to accommodate the component width |
| B0 | Dimension designed to accommodate the component length |
| K0 | Dimension designed to accommodate the component thickness |
| W | Overall width of the carrier tape |
| P1 | Pitch between successive cavity centers |

QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



*All dimensions are nominal

| Device | Package Type | Package Drawing | Pins | SPQ | Reel Diameter (mm) | Reel Width W1 (mm) | A0 (mm) | B0 (mm) | K0 (mm) | P1 (mm) | W (mm) | Pin1 Quadrant |
|---------------|--------------|-----------------|------|------|--------------------|--------------------|---------|---------|---------|---------|--------|---------------|
| DAC8830MCDREP | SOIC | D | 8 | 2500 | 330.0 | 12.4 | 6.4 | 5.2 | 2.1 | 8.0 | 12.0 | Q1 |
| DAC8831MCDREP | SOIC | D | 14 | 2500 | 330.0 | 16.4 | 6.5 | 9.0 | 2.1 | 8.0 | 16.0 | Q1 |

TAPE AND REEL BOX DIMENSIONS

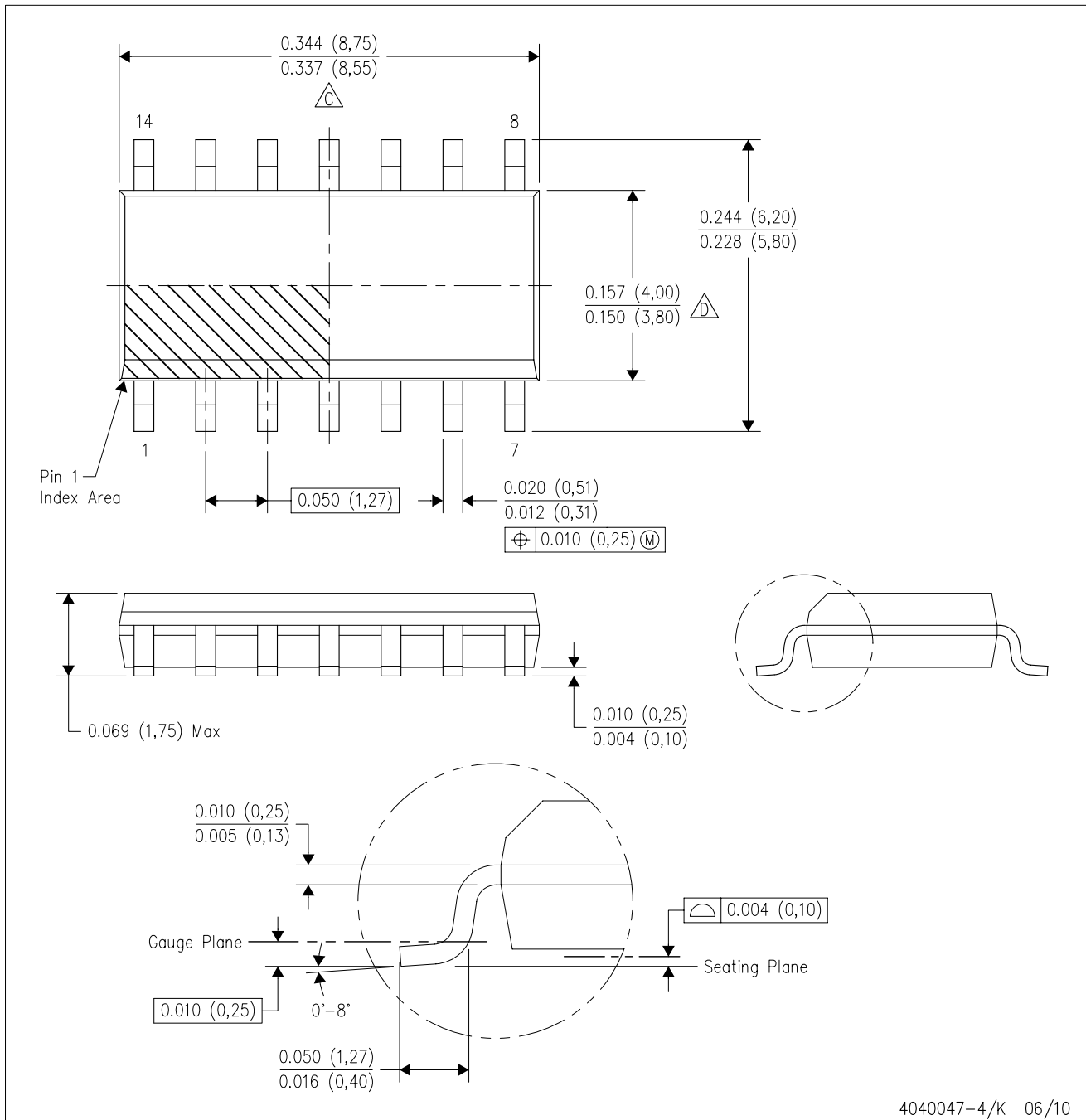


*All dimensions are nominal

| Device | Package Type | Package Drawing | Pins | SPQ | Length (mm) | Width (mm) | Height (mm) |
|---------------|--------------|-----------------|------|------|-------------|------------|-------------|
| DAC8830MCDREP | SOIC | D | 8 | 2500 | 346.0 | 346.0 | 29.0 |
| DAC8831MCDREP | SOIC | D | 14 | 2500 | 346.0 | 346.0 | 33.0 |

D (R-PDSO-G14)

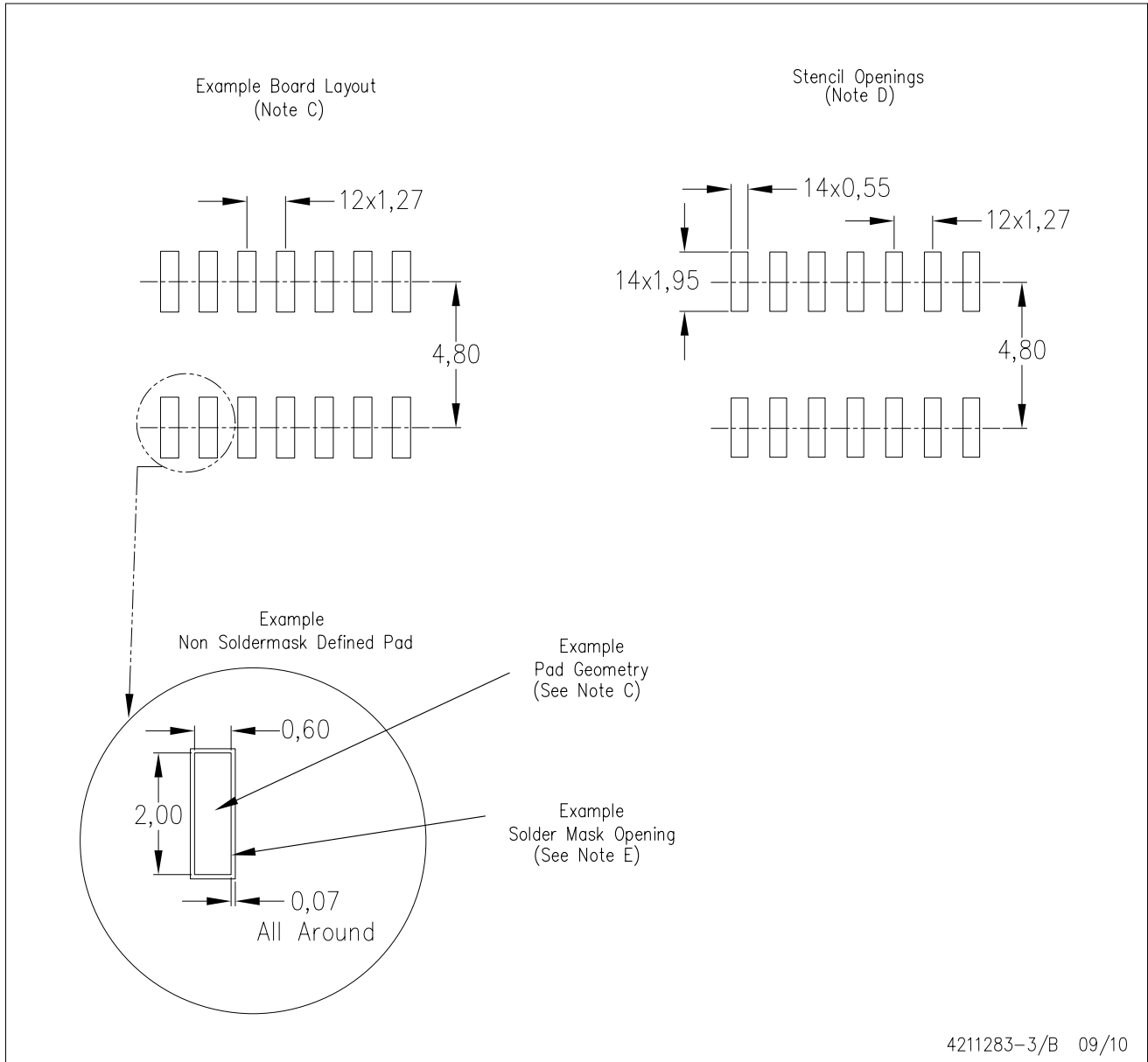
PLASTIC SMALL-OUTLINE PACKAGE



- NOTES:
- A. All linear dimensions are in inches (millimeters).
 - B. This drawing is subject to change without notice.
 - Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed .006 (0,15) per end.
 - Body width does not include interlead flash. Interlead flash shall not exceed .017 (0,43) per side.
 - E. Reference JEDEC MS-012 variation AB.

D (R-PDSO-G14)

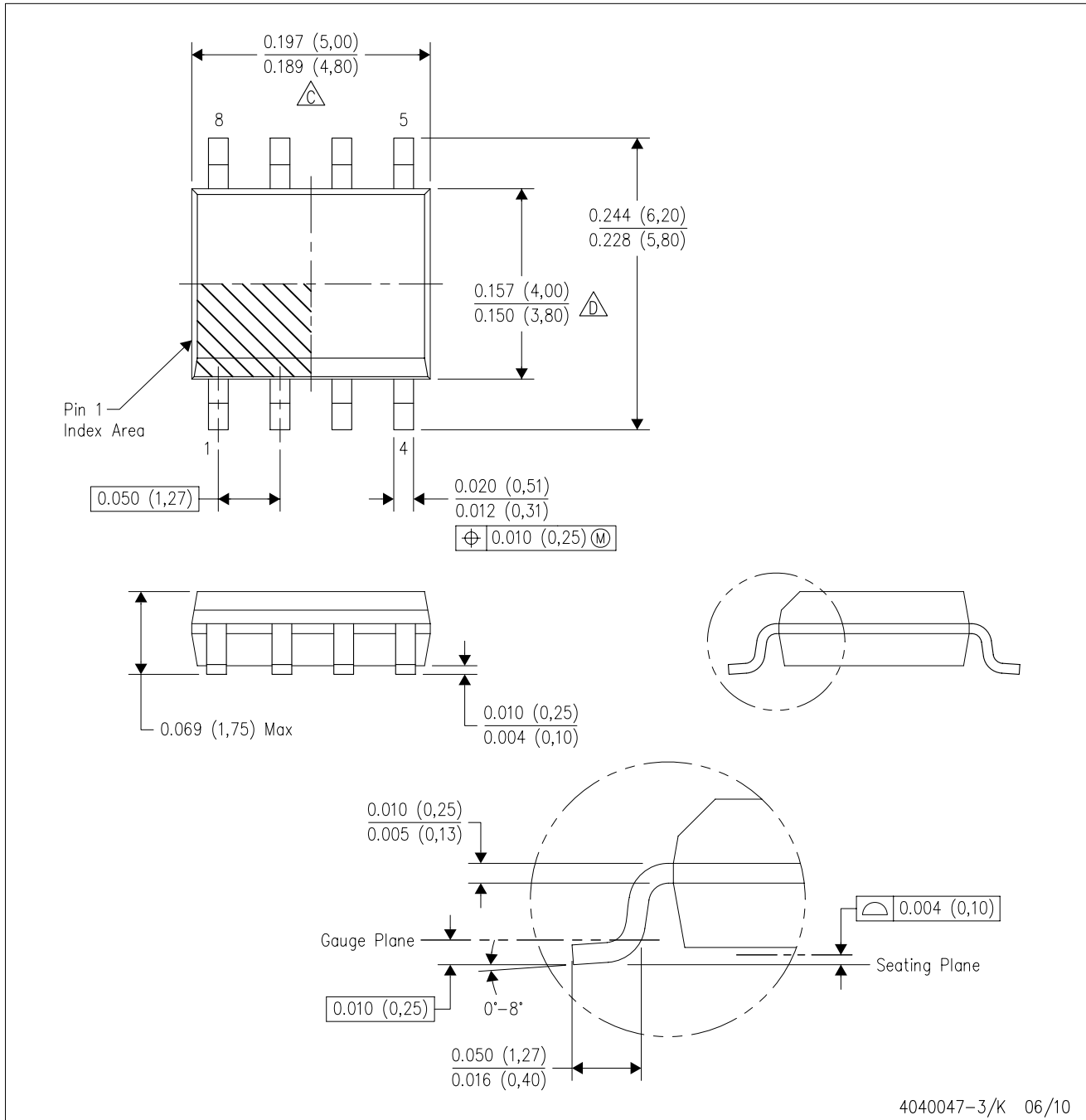
PLASTIC SMALL OUTLINE



- NOTES:
- All linear dimensions are in millimeters.
 - This drawing is subject to change without notice.
 - Publication IPC-7351 is recommended for alternate designs.
 - Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC-7525 for other stencil recommendations.
 - Customers should contact their board fabrication site for solder mask tolerances between and around signal pads.

D (R-PDSO-G8)

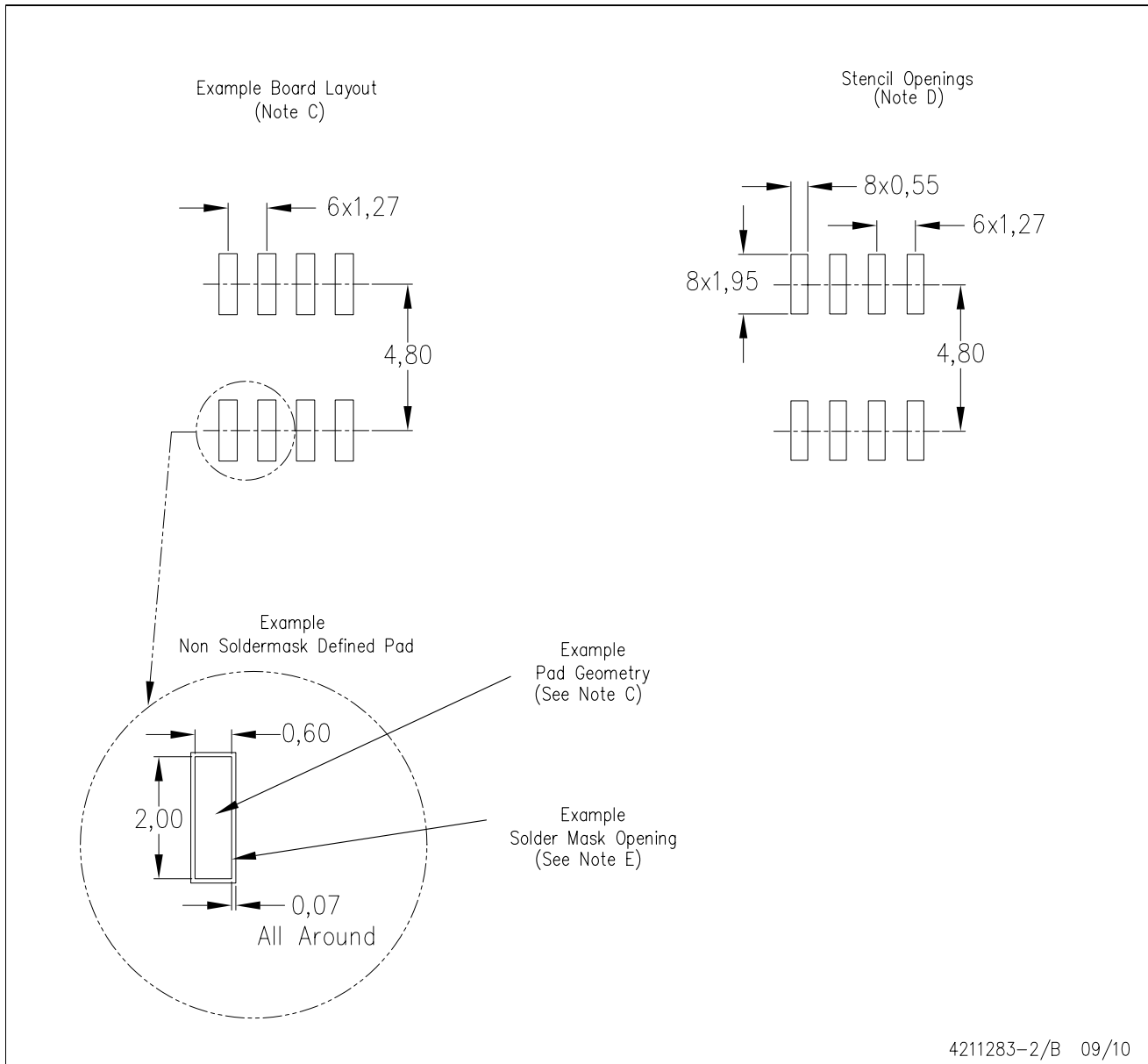
PLASTIC SMALL-OUTLINE PACKAGE



- NOTES:
- A. All linear dimensions are in inches (millimeters).
 - B. This drawing is subject to change without notice.
 - C. Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed .006 (0,15) per end.
 - D. Body width does not include interlead flash. Interlead flash shall not exceed .017 (0,43) per side.
 - E. Reference JEDEC MS-012 variation AA.

D (R-PDSO-G8)

PLASTIC SMALL OUTLINE



- NOTES:
- All linear dimensions are in millimeters.
 - This drawing is subject to change without notice.
 - Publication IPC-7351 is recommended for alternate designs.
 - Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC-7525 for other stencil recommendations.
 - Customers should contact their board fabrication site for solder mask tolerances between and around signal pads.

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